1

NCE40P40D

PRODUCT SUMMARY			
V _{DS} (V)	-40		
$R_{DS(on)}$ (Ω) at V_{GS} = -10 V	0.012		
$R_{DS(on)}(\Omega)$ at V_{GS} = -4.5 V	0.015		
I _D (A)	-60		
Configuration	Single		

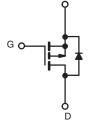
FEATURES

- TrenchFET[®] power MOSFET
- Package with low thermal resistance
- + 100 % $\rm R_g$ and UIS tested









P-Channel MOSFET

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ABSOLUTE MAXIMUM RATINGS	$(T_C = 25 \ ^{\circ}C, \text{ unless})$	otherwise noted	I)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	-40	V
Gate-Source Voltage		V _{GS}	± 20	
Continuous Drain Current	$T_C = 25 \ ^{\circ}C \ ^{a}$	- I _D	-60	
	T _C = 125 °C		-45	
Continuous Source Current (Diode Conduction) ^a		۱ _S	-60	А
Pulsed Drain Current ^b	I _{DM}	-230		
Single Pulse Avalanche Current		I _{AS}	-45	
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	80	mJ
Maximum Power Dissipation ^b	T _A = 25 °C		3.5	
	T _C = 25 °C	PD	166	W
	T _C = 125 °C		65	
Operating Junction and Storage Temperature Range		TJ, T _{stq}	-55 to +175	°C

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient	PCB Mount ^c	R _{thJA}	50	°C/W	
Junction-to-Case (Drain)		R _{thJC}	1.1	0/10	

Notes

a. Package limited.

b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

c. When mounted on 1" square PCB (FR4 material).

d. Parametric verification ongoing.



SPECIFICATIONS ($T_c = 25 \text{ °C}$, unless otherwise noted)								
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static						•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$		-40	-	-	v	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$		-	-2.5	v	
Gate-Source Leakage	I _{GSS}	V _{DS} =	0 V, $V_{GS} = \pm 20 V$	-	-	± 100	nA	
		$V_{GS} = 0 V$	V _{DS} = -40 V	-	-	-1	1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	$V_{DS} = -40 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$	-	-	-50	μA	
		$V_{GS} = 0 V$	$V_{DS} = -40 \text{ V}, \text{ T}_{J} = 175 ^{\circ}\text{C}$	-	-	-150	1	
On-State Drain Current ^a	I _{D(on)}	$V_{GS} = -10 \text{ V}$	$V_{DS} \le -5 V$	-60	-	-	А	
		$V_{GS} = -10 \text{ V}$	I _D = -17 A	-	0.012	-		
Ducia Course On Otata Decistore of		$V_{GS} = -10 \text{ V}$	I _D = -50 A, T _J = 125 °C	-	0.017	-	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = -10 V	I _D = -50 A, T _J = 175 °C	-	0.020	-		
		$V_{GS} = -4.5 V$	I _D = -14 A	-	0.015	-		
Forward Transconductance ^a	9 _{fs}	V _{DS} =	V _{DS} = -15 V, I _D = -17 A		61	-	S	
Dynamic ^b						•		
Input Capacitance	C _{iss}		V _{DS} = -25 V, f = 1 MHz	-	2872	3950	pF	
Output Capacitance	C _{oss}	$V_{GS} = 0 V$		-	508	635		
Reverse Transfer Capacitance	C _{rss}	1		-	352	440		
Total Gate Charge ^c	Qg		V _{DS} = -30 V, I _D = -50 A	-	60	80		
Gate-Source Charge ^c	Q _{gs}	$V_{GS} = -10 \text{ V}$		-	5.7	8.6	nC	
Gate-Drain Charge ^c	Q _{gd}	1		-	14.7	22		
Gate Resistance	Rg		f = 1 MHz	1.5	3	4.5	Ω	
Turn-On Delay Time ^c	t _{d(on)}			-	10	15		
Rise Time °	t _r	V _{DD} =	$V_{DD} = -20 \text{ V}. \text{ R}_{\text{I}} = 0.4 \Omega$		12	18	- ns	
Turn-Off Delay Time ^c	t _{d(off)}	$I_D \cong$ -50 Å, V_{GEN} = -10 V, R_g = 1 Ω		-	40	60		
Fall Time ^c	t _f	1	-	16	24			
Source-Drain Diode Ratings and Char	acteristics ^b							
Pulsed Current ^a	I _{SM}			-	-	-200	А	
Forward Voltage	V _{SD}	I _F =	-50 A, V _{GS} = 0 V	-	-1	-1.5	V	

Notes

a. Pulse test; pulse width $\leq 300~\mu\text{s},~\text{duty}~\text{cycle} \leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

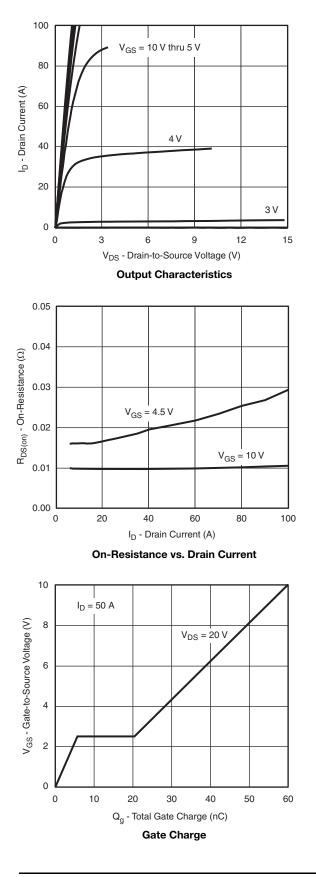
c. Independent of operating temperature.

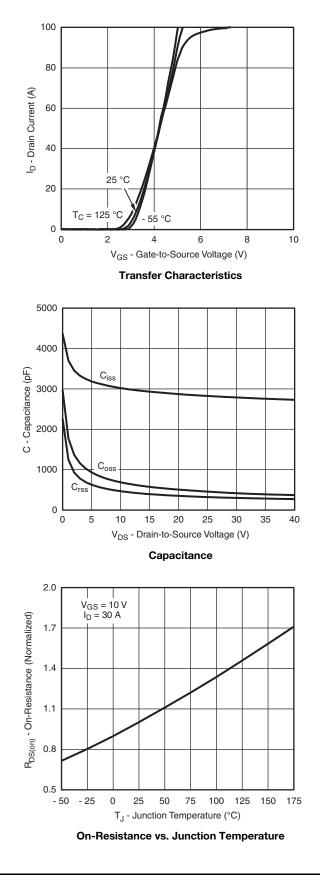
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)





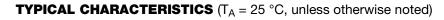


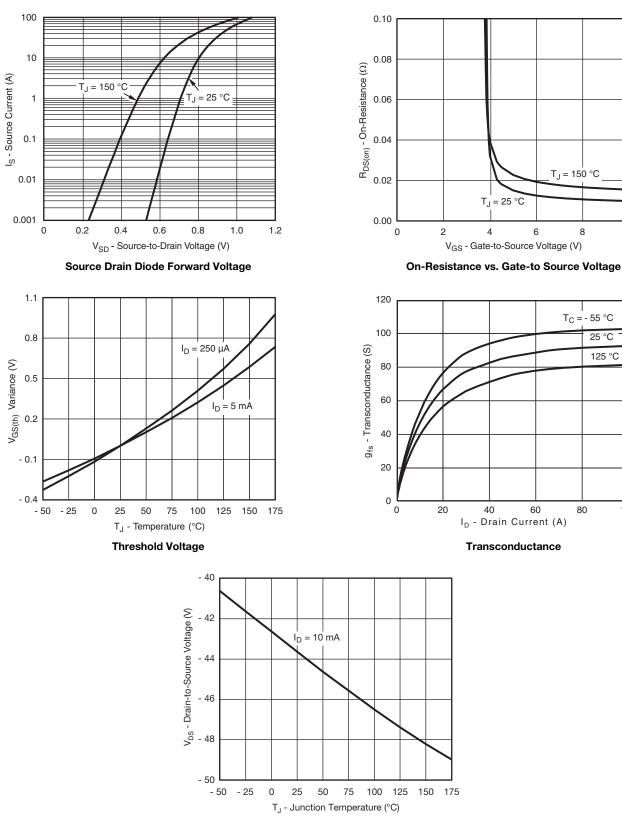
10

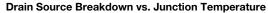
25 °C

125 °C

100

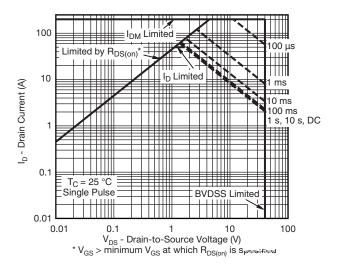




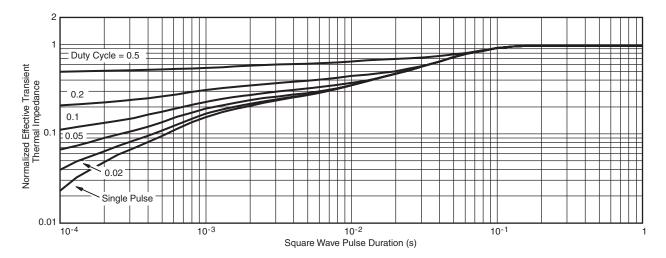




TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)

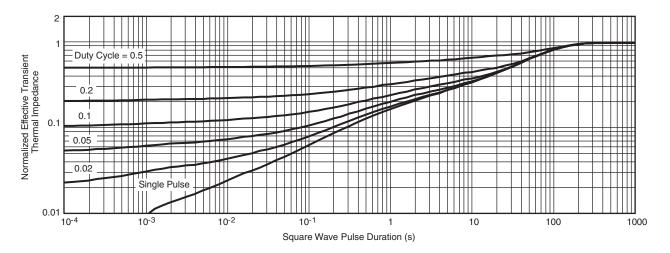


Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case





Normalized Thermal Transient Impedance, Junction-to-Ambient

Note

• The characteristics shown in the two graphs

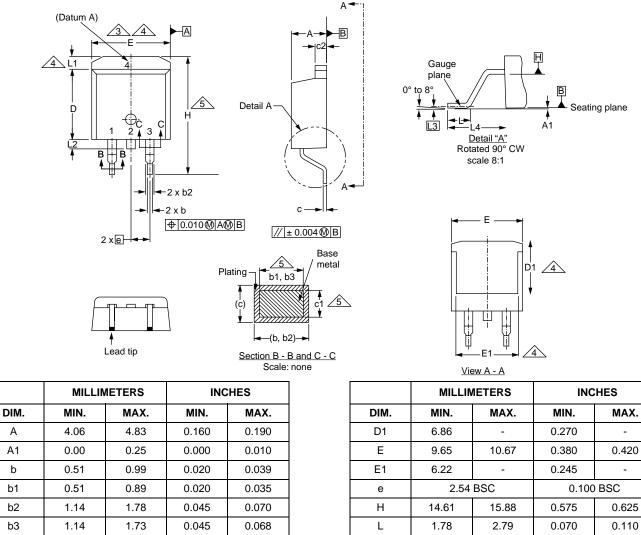
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-263AB (HIGH VOLTAGE)



b3	1.14	1.73	0.045	0.068		
С	0.38	0.74	0.015	0.029		
c1	0.38	0.58	0.015	0.023		
c2	1.14	1.65	0.045	0.065		
D	8.38	9.65	0.330	0.380		
ECN: S-82 DWG: 597	110-Rev. A, ′ 0	15-Sep-08				

Notes

А

A1

b

b1

b2

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.

L1

L2

L3

L4

-

-

4.78

1.65

1.78

5.28

0.25 BSC

-

-

0.188

0.010 BSC

0.066

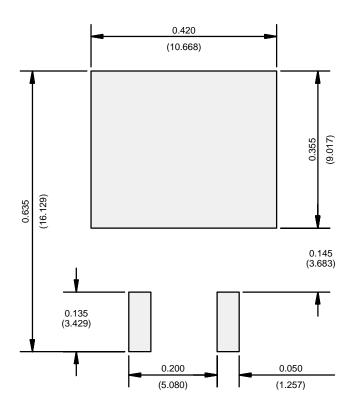
0.070

0.208

- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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